INTERNATIONAL SEARCH REPORT

PCT/US2004/018159

		PC	T/US2004/018159
IPC 7	GO1R31/307 H01L21/66		
According	to International Patent Classification (IPC) or to both national classif	institut and IDO	
B. FIELDS	SEARCHED		
Minimum d	ocumentation searched (classification system followed by classification system)	ation symbols)	
IPC 7	GO1R HO1L HO1J	,	
Documenta	ation searched other than minimum documentation to the extent that	such documents are included i	n the fields searched
Electronic	data base consulted during the International search (name of data b	ase and, where practical search	th terms used)
EPO-In	ternal, WPI Data, PAJ	,	
C. DOCUM	ENTS CONSIDERED TO BE RELEVANT		
Category °	Citation of document, with indication, where appropriate, of the re		
	where appropriate, or the n	elevant passages	Relevant to daim No.
X	US 2001/022345 A1 (ISHIMOTO TORU 20 September 2001 (2001-09-20))	1-8, 10-23, 25-42
	figures 1-4 paragraph '0002! - paragraph '00 paragraph '0010! - paragraph '00 paragraph '0020! - paragraph '00 paragraph '0032! paragraph '0034! - paragraph '00	12! 28!	
X	KEIZO YAMADA ET AL.: "An in-lin monitoring method using electron induced substrate current" MICROELECTRONICS RELIABILITY, 20 455-459, XP001152421 cited in the application the whole document	1-6, 8-11,13, 16, 18-26, 28,31-42	
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X Furth	ner documents are listed in the continuation of box C.	X Patent family member	s are listed in annex.
"A" docume conside "E" earlier de filing de "L" docume which i citation "O" docume other n	nt which may throw doubts on priority claim(s) or is cited to establish the publication date of another or orther special reason (as specified) ant referring to an oral disclosure, use, exhibition or	"X" document of particular rele cannot be considered now involve an inventive step. "Y" document of particular rele cannot be considered to la document is combined with ments, such combination in the art.	conlict with the application but iniciple or theory underlying the wance; the claimed invention rel or cannot be considered to when the document is taken alone wance; the claimed invention novolve an inventive step when the thone or more other such docubeling obvious to a person skilled
	actual completion of the international search	*&* document member of the s Date of mailing of the inten	
	November 2004	11/11/2004	пашна зеагол герол
Name and mailing address of the ISA		Authorized officer	
	European Patent Office, P.B. 5818 Patentlaan 2 NL - 2280 HV Rijswijk Tel. (+31-70) 340-2040, Tx. 31 651 epo nt, Fax: (+31-70) 340-3016	Höller, H	
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